


<b>Search Notes</b>  	<b>Application/Control No.</b>  10525635	<b>Applicant(s)/Patent Under Reexamination</b>  FURUKAWA ET AL.
	<b>Examiner</b>  DANIEL TEKLE	<b>Art Unit</b>  2621

<b>SEARCHED</b>			
<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>
386	40	03/01/09	D.T.

<b>SEARCH NOTES</b>		
<b>Search Notes</b>	<b>Date</b>	<b>Examiner</b>
EAST SEARCH DATA BASE (USPGPUB; USPTO; USOCR; DERWENT; JPO; EPO)	03/01/09	D.T.
SEARCH QUERY ATTACHED	03/01/09	D.T.
INVENTOR SEARCH	03/01/09	D.T.
NPL	03/01/09	D.T.
SEARCH UPDATED	08/20/09	D.T.

<b>INTERFERENCE SEARCH</b>			
<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>

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